TOSHIBA Field-Effect Transistor Silicon N / P Channel MOS Type

SSM6L35FE

- High-Speed Switching Applications
- Analog Switch Applications
- N-ch: 1.2-V drive P-ch: 1.2-V drive
- N-ch, P-ch, 2-in-1
- Low ON-resistance Q1 N-ch: $R_{on} = 20 \Omega (max) (@V_{GS} = 1.2 V)$

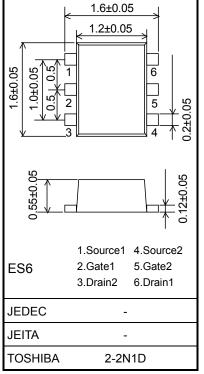
: $R_{on} = 8 \Omega (max) (@V_{GS} = 1.5 V)$: $R_{on} = 4 \Omega (max) (@V_{GS} = 2.5 V)$

: $R_{on} = 3 \Omega (max) (@V_{GS} = 4.0 V)$

- Q2 P-ch: R_{on} = 44 Ω (max) (@V_{GS} = -1.2 V)
 - : R_{on} = 22 Ω (max) (@V_{GS} = -1.5 V)
 - : R_{on} = 11 Ω (max) (@V_{GS} = -2.5 V)
 - : R_{on} = 8 Ω (max) (@V_{GS} = -4.0 V)

Q1 Absolute Maximum Ratings (Ta = 25°C)

| Characteristics | | Symbol | Rating | Unit | |
|----------------------|-------|------------------|--------|------|--|
| Drain-source voltage | | V _{DSS} | 20 | V | |
| Gate-source voltage | | V _{GSS} | ±10 | V | |
| Drain current | DC | ۱ _D | 180 | | |
| | Pulse | I _{DP} | 360 | mA | |



Weight: 3.0 mg (typ.)

Q2 Absolute Maximum Ratings (Ta = 25°C)

| Characteristics | | Symbol | Rating | Unit |
|----------------------|-------|------------------|--------|------|
| Drain-source voltage | | V _{DSS} | -20 | V |
| Gate-source voltage | | V _{GSS} | ±10 | V |
| Drain current | DC | ۱ _D | -100 | mA |
| | Pulse | I _{DP} | -200 | ША |

Absolute Maximum Ratings (Ta = 25 °C) (Common to the Q1, Q2)

| Characteristic | Symbol | Rating | Unit | |
|---------------------------|-------------------------|------------|------|--|
| Drain power dissipation | P _D (Note 1) | 150 | mW | |
| Channel temperature | T _{ch} | 150 | °C | |
| Storage temperature range | T _{stg} | -55 to 150 | °C | |

Note: Using continuously under heavy loads (e.g. the application of high temperature/current/voltage and the significant change in temperature, etc.) may cause this product to decrease in the reliability significantly even if the operating conditions (i.e. operating temperature/current/voltage, etc.) are within the absolute maximum ratings.

Please design the appropriate reliability upon reviewing the Toshiba Semiconductor Reliability Handbook ("Handling Precautions"/"Derating Concept and Methods") and individual reliability data (i.e. reliability test report and estimated failure rate, etc).

Note 1: Total rating

Mounted on an FR4 board

 $(25.4 \text{ mm} \times 25.4 \text{ mm} \times 1.6 \text{ mm}, \text{Cu Pad: } 0.135 \text{ mm}^2 \times 6)$

Start of commercial production 2008-03

Unit: mm

Q1 Electrical Characteristics (Ta = 25°C)

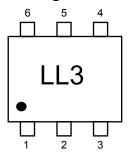
| Chara | acteristics | Symbol | Test Condition | | Min | Тур. | Max | Unit | |
|------------------------------|---|----------------------|---|----------|-----|------|------|------|--|
| Gate leakage cur | rent | I _{GSS} | $V_{GS}=\pm 10~V,~V_{DS}=0V$ | | | — | ±10 | μA | |
| Drain-source bre | akdown voltage | V (BR) DSS | $I_D = 0.1 \text{ mA}, V_{GS} = 0V$ | | 20 | _ | _ | V | |
| Drain cutoff curre | nt | I _{DSS} | $V_{DS} = 20 V, V_{GS} = 0V$ | | _ | _ | 1 | μA | |
| Gate threshold vo | oltage | V _{th} | $V_{DS} = 3 V, I_D = 1 mA$ | | 0.4 | _ | 1.0 | V | |
| Forward transfer | admittance | Y _{fs} | $V_{DS} = 3 V, I_{D} = 50 mA$ | (Note 2) | 115 | _ | _ | mS | |
| | | R _{DS} (ON) | I _D = 50 mA, V _{GS} = 4 V | (Note 2) | _ | 1.5 | 3 | Ω | |
| Drain–source ON-resistance | $I_D = 50 \text{ mA}, \text{ V}_{GS} = 2.5 \text{ V}$ | | (Note 2) | _ | 2 | 4 | | | |
| | $I_D = 5 \text{ mA}, V_{GS} = 1.5 \text{ V}$ | | (Note 2) | _ | 3 | 8 | | | |
| | | | $I_D = 5 \text{ mA}, V_{GS} = 1.2 \text{ V}$ | (Note 2) | _ | 5 | 20 | | |
| Input capacitance |) | C _{iss} | | | _ | 9.5 | _ | | |
| Reverse transfer capacitance | | C _{rss} | $V_{DS} = 3 \text{ V}, \text{ V}_{GS} = 0 \text{ V}, \text{ f} = 1 \text{ MHz}$ | | _ | 4.1 | _ | pF | |
| Output capacitand | се | C _{oss} | C _{oss} | | _ | 9.5 | _ | 1 | |
| | Turn-on time | t _{on} | V _{DD} = 3 V, I _D = 50 mA, | | _ | 115 | _ | | |
| Switching time | Turn-off time | t _{off} | $V_{GS} = 0$ to 2.5 V | | _ | 300 | _ | ns | |
| Drain-source forward voltage | | V _{DSF} | I _D = - 180 mA, V _{GS} = 0V | (Note 2) | _ | -0.9 | -1.2 | V | |

Q2 Electrical Characteristics (Ta = 25°C)

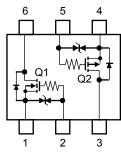
| Charac | teristics | Symbol | Test Condition | | Min | Тур. | Max | Unit | |
|------------------------------|---------------------------------|----------------------|---|----------|------|------|------|------|--|
| Gate leakage curre | ent | I _{GSS} | $V_{GS} = \pm 10 \text{ V}, V_{DS} = 0 \text{ V}$ | | _ | _ | ±10 | μA | |
| Drain-source breal | kdown voltage | V (BR) DSS | I_{D} = -0.1 mA, V_{GS} = 0 V | | -20 | _ | _ | V | |
| Drain cutoff current | t | I _{DSS} | $V_{DS} = -20 \text{ V}, \text{ V}_{GS} = 0 \text{ V}$ | | _ | _ | -1 | μA | |
| Gate threshold volt | age | V _{th} | $V_{DS} = -3 V, I_D = -1 mA$ | | -0.4 | _ | -1.0 | V | |
| Forward transfer ad | dmittance | Y _{fs} | $V_{DS} = -3 V, I_D = -50 mA$ (Note 2) | | 77 | - | _ | mS | |
| Drain–source ON-resistance | | R _{DS} (ON) | I_{D} = -50 mA, V_{GS} = -4 V | (Note 2) | | 4.3 | 8 | Ω | |
| | | | I _D = -50 mA, V _{GS} = -2.5 V | (Note 2) | _ | 5.6 | 11 | | |
| | | | $I_{D} = -5 \text{ mA}, V_{GS} = -1.5 \text{ V}$ | (Note 2) | _ | 8.2 | 22 | | |
| | | | $I_D = -2 \text{ mA}, V_{GS} = -1.2 \text{ V}$ | (Note 2) | _ | 11 | 44 | | |
| Input capacitance | it capacitance C _{iss} | | | _ | 12.2 | _ | | | |
| Reverse transfer capacitance | | C _{rss} | V_{DS} = -3 V, V_{GS} = 0 V, f = 1 MHz | | | 6.5 | _ | pF | |
| Output capacitance | 9 | C _{oss} | | | | 10.4 | _ | | |
| Switching time | Turn-on time | t _{on} | V _{DD} = -3 V, I _D = -50 mA, V _{GS} = 0 to -2.5 V | | _ | 175 | — | | |
| | Turn-off time | t _{off} | | | — | 251 | — | ns | |
| Drain-source forward voltage | | V _{DSF} | $I_D = 100 \text{ mA}, V_{GS} = 0 \text{ V}$ | (Note 2) | — | 0.83 | 1.2 | V | |

Note 2: Pulse test

Marking



Equivalent Circuit (top view)



90%

toff

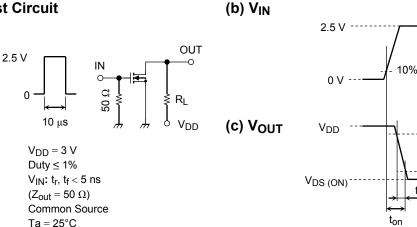
10%

90%

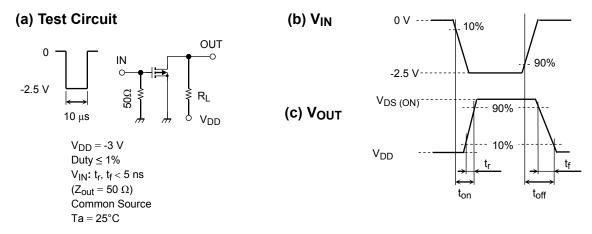
t.

Q1 Switching Time Test Circuit

(a) Test Circuit



Q2 Switching Time Test Circuit



Q1 Usage Considerations

Let V_{th} be the voltage applied between gate and source that causes the drain current (I_D) to below (1 mA for the Q1 of the SSM6L35FE). Then, for normal switching operation, $V_{GS(on)}$ must be higher than V_{th} , and $V_{GS(off)}$ must be lower than V_{th} . This relationship can be expressed as: $V_{GS(off)} < V_{th} < V_{GS(on)}$. Take this into consideration when using the device.

Q2 Usage Considerations

Let V_{th} be the voltage applied between gate and source that causes the drain current (I_D) to below (-1 mA for the Q2 of the SSM6L35FE). Then, for normal switching operation, $V_{GS(on)}$ must be higher than V_{th} , and $V_{GS(off)}$ must be lower than V_{th} . This relationship can be expressed as: $V_{GS(off)} < V_{th} < V_{GS(on)}$.

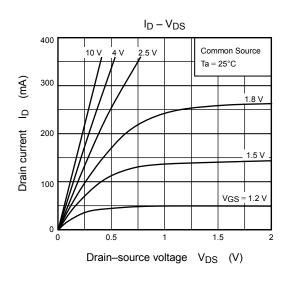
Take this into consideration when using the device.

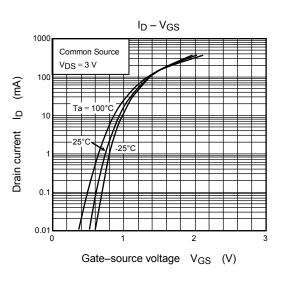
Handling Precaution

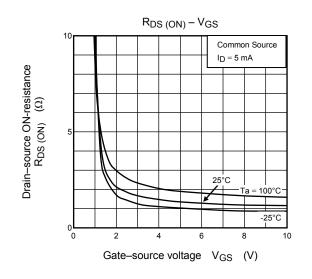
When handling individual devices that are not yet mounted on a circuit board, make sure that the environment is protected against electrostatic discharge. Operators should wear antistatic clothing, and containers and other objects that come into direct contact with devices should be made of antistatic materials.

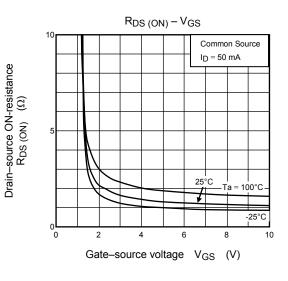
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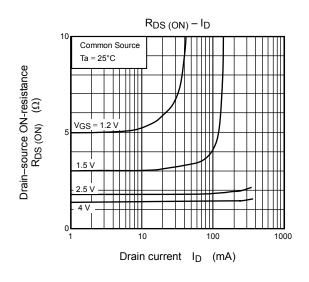
Q1 (N-ch MOSFET)

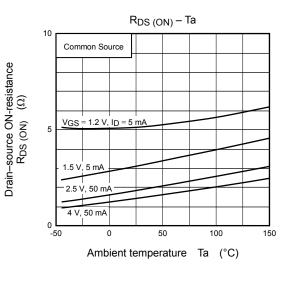






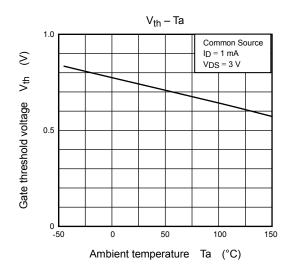


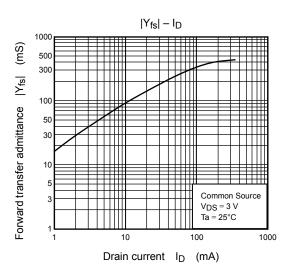


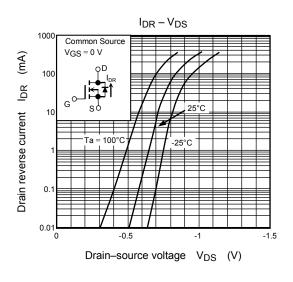


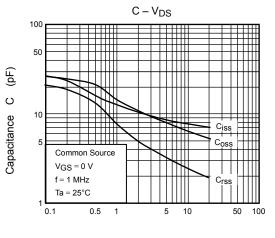
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Q1 (N-ch MOSFET)

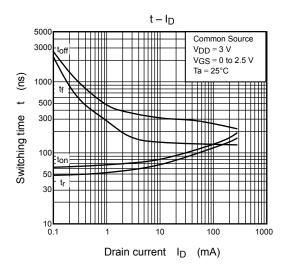




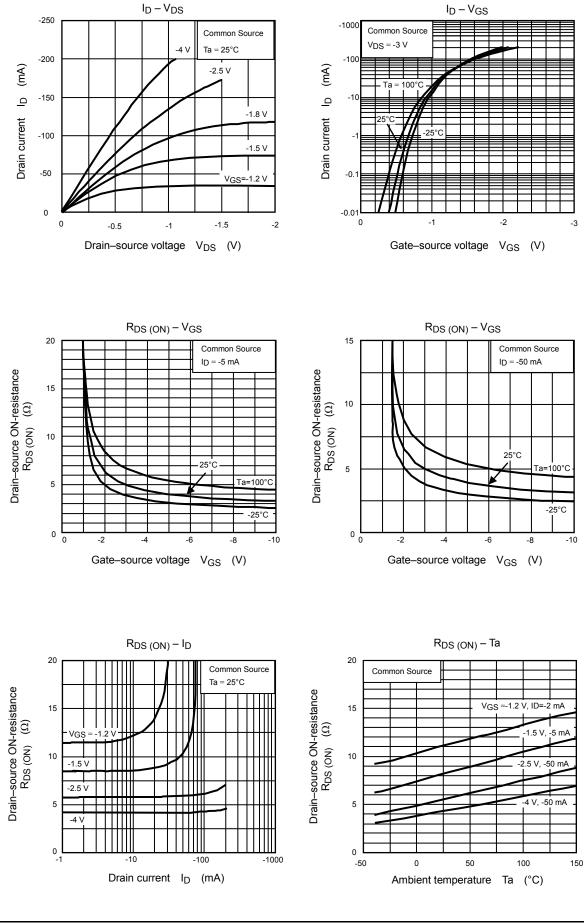




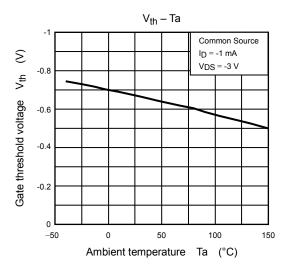


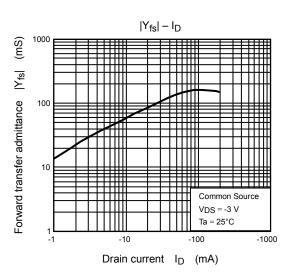


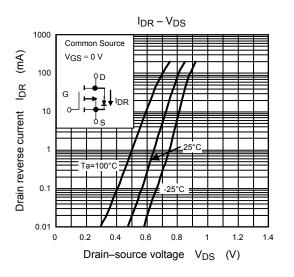
Q2 (P-ch MOSFET)

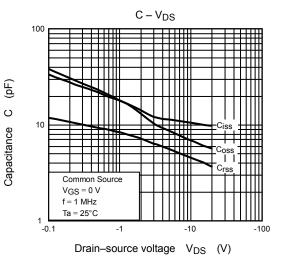


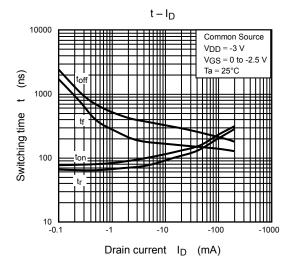
Q2 (P-ch MOSFET)



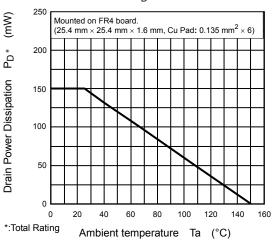








P_D *– Ta



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